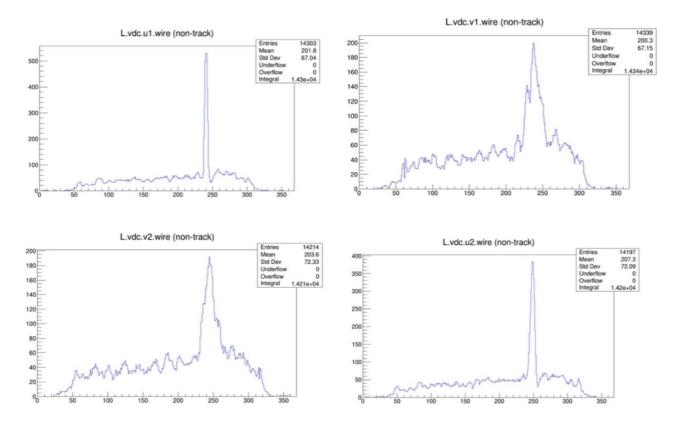
# **VDC Tracking Issue**

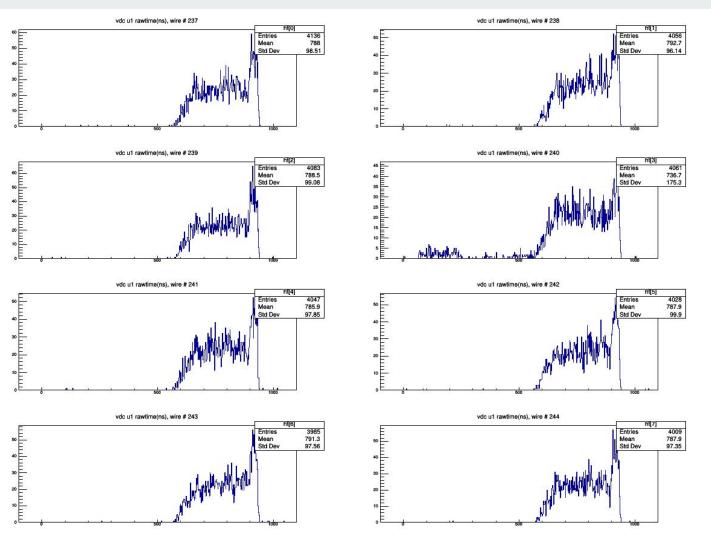
Hanjie Liu, Shujie Li Jun 05, 2018

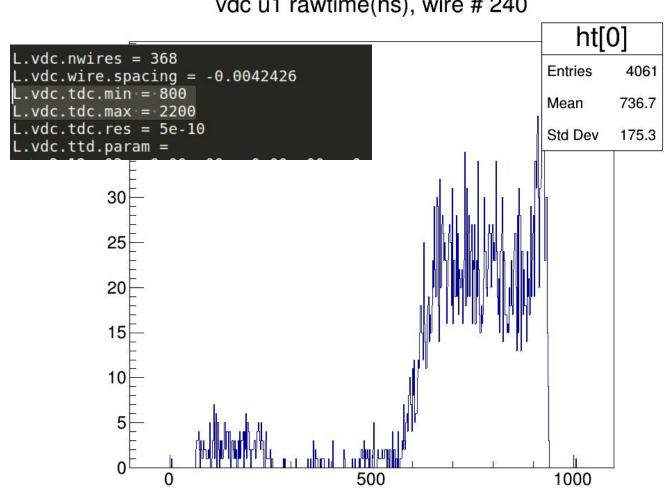
#### **Questions:**

#### Lots of non-track potential electron events are around wire 240-250

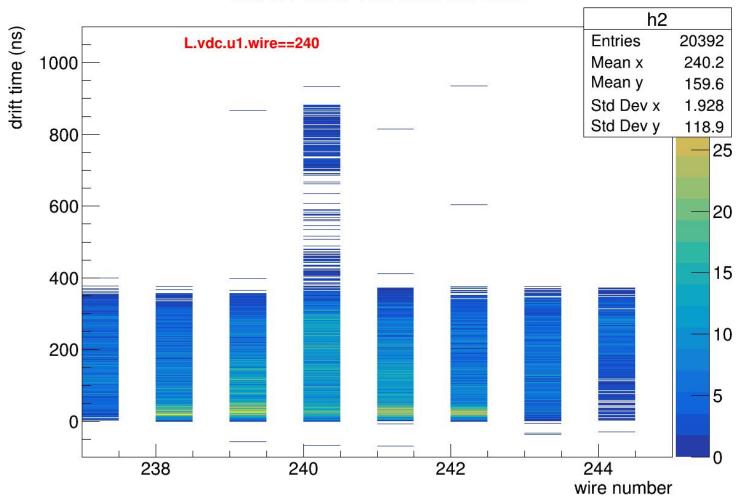


#### Run 3142 is used to make plots unless specified.

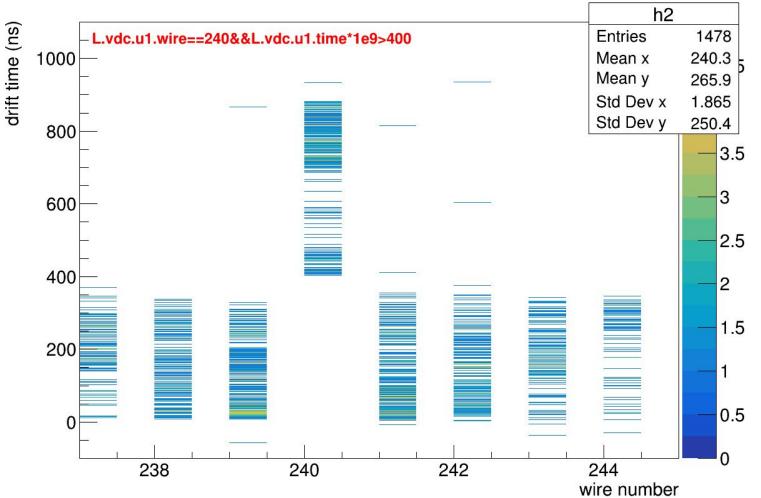




vdc u1 rawtime(ns), wire # 240



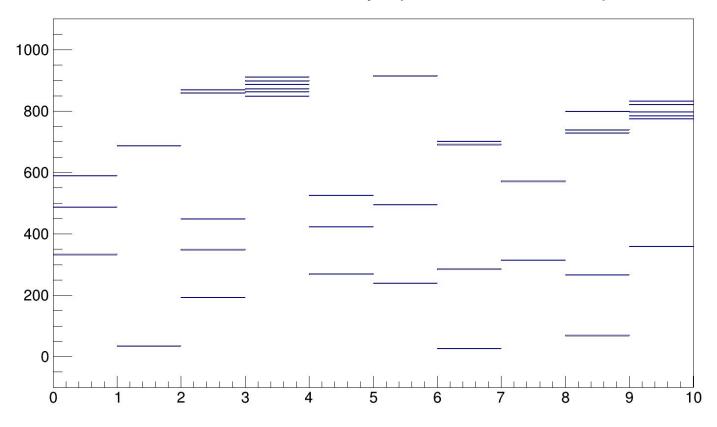
vdc u1 time v.s. wire number

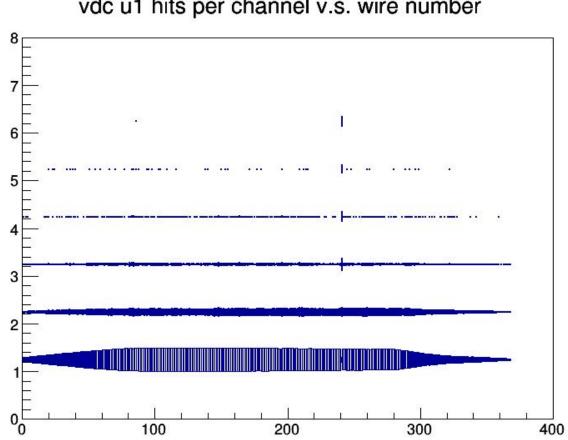


### vdc u1 time v.s. wire number

### Wire 240 has a lot of multi hits: bad wire? Bad electronics?

L.vdc.u1.time\*1e9:Entry\$ {L.vdc.u1.wire==240}





### vdc u1 hits per channel v.s. wire number

## Wire 240 Tracking Quality Check:

## Q:

- 1. Percentage of "bad" hit from wire 240
- 2. When the wire 240 tdc value passed hard\_cut but has multi hits, can we trust it?

## Wire 240 Tracking Quality Check:

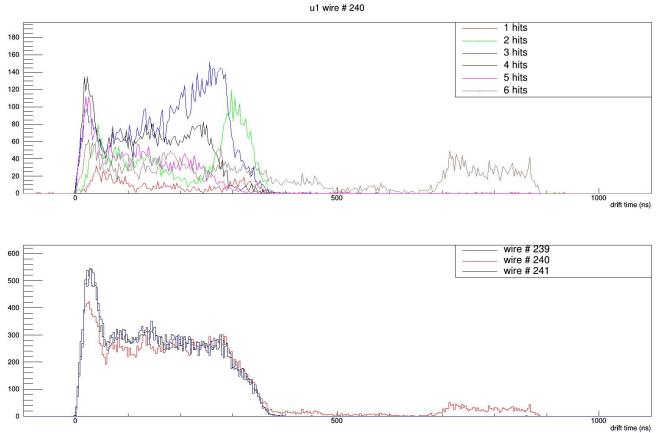
1. Find potential good electron events:

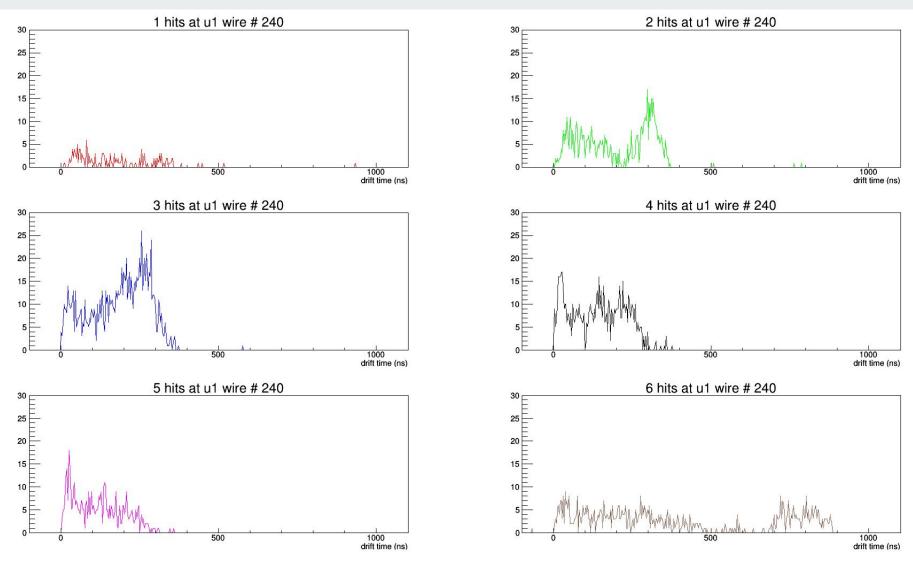
TCut pid = "DL.bit2>0&&L.cer.asum\_c>2000 && (L.prl1.e+L.prl2.e)>(HacL\_D1\_P0rb\*800)";

2. Look at hits / tracks per wire

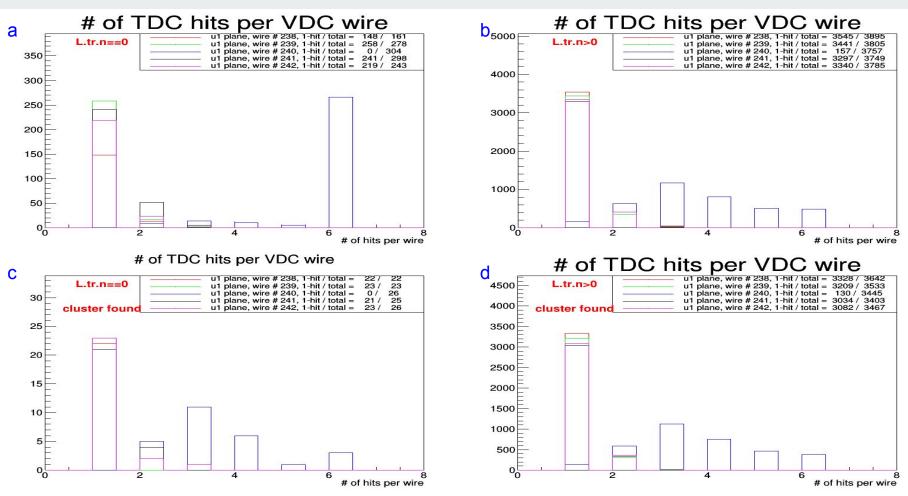
3. If no track, is the fired wire not used for cluster or cluster formed but not used for track ??

"L.vdc.u1.clbeg[0]<=240&&L.vdc.u1.clend[0]>=240&&L.vdc.u1.wire==240"

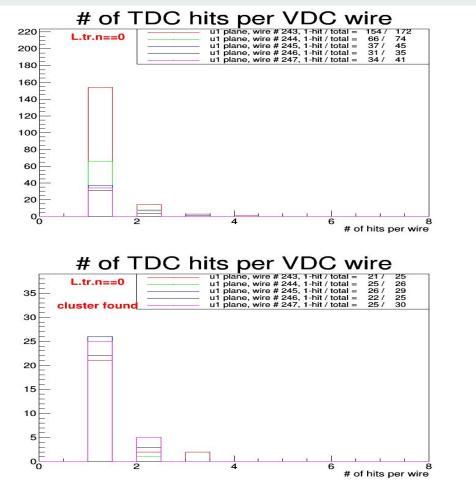




#### Wire 238-242

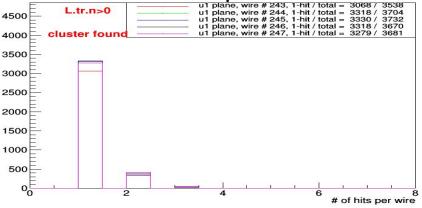


#### Wire 243-247

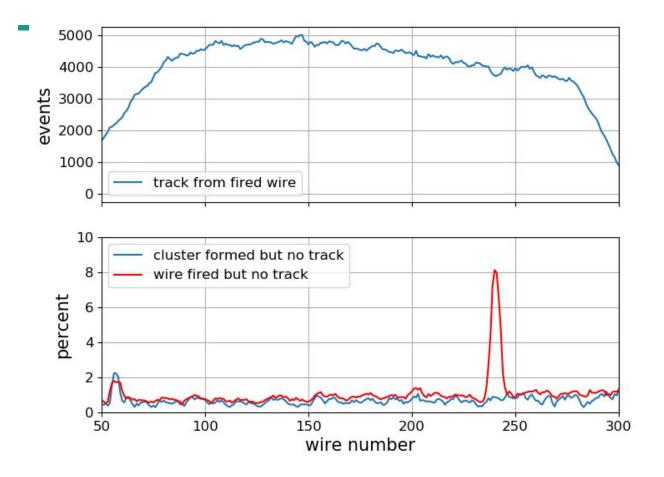


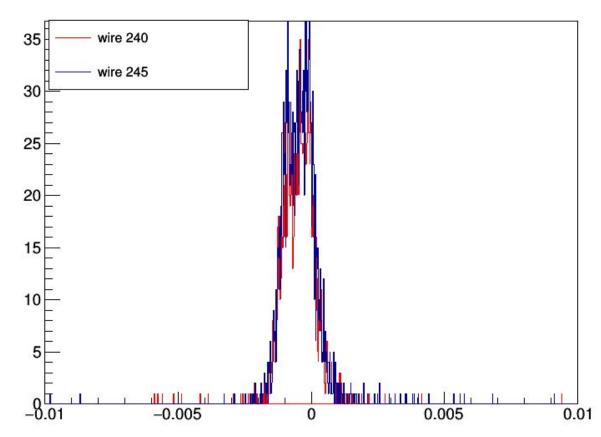
#### # of TDC hits per VDC wire 5000 L.tr.n>0 U1 plane, wire # 243, 1-hit / total = 3282 / 3813 U1 plane, wire # 244, 1-hit / total = 3508 / 3935 U1 plane, wire # 246, 1-hit / total = 3516 / 3962 4000 U1 plane, wire # 247, 1-hit / total = 3516 / 3962 400





Run 3142, U1 plane





#### distance from track: trdist-dist

## **Conclusion**:

- 1. U1 wire 240 is noisy (multi-hits) across the spring run period
- 2. When analyzer was able to find cluster with wire 240, the track looks OK (?)
- 3. 8% of hit from the wire could be good but didn't used to for cluster